

Notice of References Cited

Application/Control No.

10/766,591

Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Examiner

CHRYSTINA ZELASKIEWICZ

Art Unit

3621

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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|------------------|----------------|
| * | A | US-2003/0050114 | 03-2003 | Leen et al. | 463/25 |
| * | B | US-6,758,754 | 07-2004 | Lavanchy et al. | 463/42 |
| * | C | US-6,468,155 | 10-2002 | Zucker et al. | 463/23 |
| * | D | US-2003/0163729 | 08-2003 | Buchegger, Sonja | 713/201 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
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| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

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